

<b>Notice of References Cited</b>	Application/Control No. 10/751,447	Applicant(s)/Patent Under Reexamination SHIMIZU ET AL.	
	Examiner Jeff Wollschlager	Art Unit 1732	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0166270	08-2004	Yoshida et al.	428/036.91
*	B	US-11/299092	12-2005	Yoshida et al.	428/036.91
*	C	US-6,183,869	02-2001	Okuda et al.	428/411.1
*	D	US-5,345,300	09-1994	Uehara et al.	399/329
*	E	US-5,695,878	12-1997	Badesha et al.	428/334
*	F	US-2004/0040739	03-2004	Yoshimura et al.	174/255
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.